TESTING
NVLAP LAB CODE 600118-0

HAC RF TEST REPORT

No. I21Z60271-SEM01

For

Sun Cupid Technology (HK) Ltd.

LTE Smart Phone

Model Name: S5502L, A11L, NUU A11L

With

Hardware Version: V00

Software Version: S5502L-VZ-RGO-MV01602-01.f

FCC ID: 2ADINS5502L

Results Summary: M Category = M3

Issued Date: 2021-4-2

Note:

The test results in this test report relate only to the devices specified in this report. This report shall not be reproduced except in full without the written approval of CTTL.

Test Laboratory:

Telecommunication Technology Labs, CAICT
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REPORT HISTORY

Report Number	Revision	Issue Date	Description
I21Z60271-SEM01	Rev.0	2021-3-23	Initial creation of test report
I21Z60271-SEM01	Rev.1	2021-4-2	1. Delete the note on the page 1 2. Update the lab name and address on page 1&5 3. Add the annex F for the accreditation certificate on the page 60

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1 Test Laboratory

1.1 Testing Location

Company Name:	Telecommunication Technology Labs, CAICT
Address:	No. 52, Huayuan North Road, Haidian District, Beijing, P. R. China 100191.
Lab number	12389A-1

1.2 Testing Environment

Temperature:	18°C~25°C,
Relative humidity:	30%~ 70%
Ground system resistance:	< 0.5 Ω
Ambient noise is checked and found very low and in compliance with requirement of standards. Reflection of surrounding objects is minimized and in compliance with requirement of standards	

1.3 Project Data

Project Leader:	Qi Dianyuan
Test Engineer:	Lin Xiaojun
Testing Start Date:	March 10, 2021
Testing End Date:	March 13, 2021

1.4 Signature

林晓军

Lin Xiaojun

(Prepared this test report)

Qi Dianyuan

(Reviewed this test report)

陆冰松

Lu Bingsong

Deputy Director of the laboratory

(Approved this test report)

2 Client Information

2.1 Applicant Information

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2.2 Manufacturer Information

Company Name:	Sun Cupid Technology (HK) Ltd.
Address/Post	16/F, CEO Tower, 77 Wing Hong Street, Cheung Sha Wan, Kowloon, Hong Kong.
Contact Person:	Danny Sit
Contact Email:	danny.sit@suncupid.com
Telephone:	852 2725 0161
Fax	\

3 Equipment Under Test (EUT) and Ancillary Equipment (AE)

3.1 About EUT

Description:	LTE Smart Phone
Model name:	S5502L, A11L, NUU A11L
Operating mode(s):	GSM850/900/1800/1900, WCDMAB2/B4/B5, BT, Wi-Fi, LTE Band 2/4/5/12/13/25/26/66/71/41

3.2 Internal Identification of EUT used during the test

EUT ID*	IMEI	HW Version	SW Version
EUT1	355386270003696	V00	S5502L-VZ-RGO-MV01602-01.f

*EUT ID: is used to identify the test sample in the lab internally.

Note: It is performed to test HAC with the EUT1

3.3 Internal Identification of AE used during the test

AE ID*	Description	Model	SN	Manufacturer
AE1	Battery	NUBS5502	XJDVKCACABACF01321	NINGBO VEKEN BATTERY CO., LTD

*AE ID: is used to identify the test sample in the lab internally.

3.4 Air Interfaces / Bands Indicating Operating Modes

Air-interface	Band(MHz)	Type	C63.19/tested	Simultaneous Transmissions	Name of Voice Service
GSM	850	VO	Yes	BT, WLAN	CMRS Voice
	1900				
WCDMA (UMTS)	850	VO	NO(1)	BT, WLAN	CMRS Voice
	1700				
	1900				
LTE TDD	Band41	V/D	Yes	BT, WLAN	VoLTE
LTE FDD	Band12/13/25/26/66/71	V/D	NO(1)	BT, WLAN	VoLTE
BT	2450	DT	NA	GSM,WCDMA ,LTE	NA
WLAN	2450	V/D	NO(1)	GSM,WCDMA ,LTE	NA
WLAN	5G	V/D	NO(1)	GSM,WCDMA ,LTE	NA

NA: Not Applicable VO: Voice Only V/D: CMRS and IP Voice Service over Digital Transport
DT: Digital Transport

* HAC Rating was not based on concurrent voice and data modes, Non current mode was found to represent worst case rating for both M and T rating

Note1= The air interface is exempted from testing by low power exemption that its average antenna input power plus its MIF is ≤17 dBm, and is rated as M4.

Note2=This device supports both LTE B2/4/5 and LTE B25/66/26.Since the supported frequency span for LTE B2/4/5 falls completely within the supports frequency span for LTE B25/26/66, both LTE bands have the same target power, and both LTE bands share the same transmission path; therefore, HAC was only assessed for LTE 25/66/26.

4 Maximum Output Power

GSM 850MHz	Conducted Power (dBm)		
	Channel 251(848.8MHz)	Channel 190(836.6MHz)	Channel 128(824.2MHz)
Voice	33.2	33.2	33.2
GSM 1900MHz	Conducted Power(dBm)		
	Channel 810(1909.8MHz)	Channel 661(1880MHz)	Channel 512(1850.2MHz)
Voice	29.8	29.8	29.8
WCDMA 850MHz	Conducted Power (dBm)		
	Channel 4233(846.6MHz)	Channel 4182(836.4MHz)	Channel 4132(826.4MHz)
RMC	23.1	23.1	23.1
WCDMA 1700MHz	Conducted Power (dBm)		
	Channel 1513 (1752.6MHz)	Channel 1412 (1732.4MHz)	Channel 1312 (1712.4MHz)
RMC	23.1	23.1	23.1
WCDMA 1900MHz	Conducted Power (dBm)		
	Channel 9538(1907.6MHz)	Channel 9400(1880MHz)	Channel 9262(1852.4MHz)
RMC	23	23	23
LTE Band12	Conducted Power (dBm)		
	Channel 23130(711MHz)	Channel 23095(707.5MHz)	Channel23060(704MHz)
QPSK	23.6	23.6	23.6
16QAM	22.6	22.6	22.6
LTE Band13	Conducted Power (dBm)		
	Channel 23230(782MHz)		
QPSK	23.2		
16QAM	22.2		
LTE Band25	Conducted Power (dBm)		
	Channel 26590(1905MHz)	Channel 26365(1883MHz)	Channel 26140(1860MHz)
QPSK	23.9	23.9	23.9
16QAM	22.9	22.9	22.9
LTE Band26	Conducted Power (dBm)		
	Channel 26965(841.5MHz)	Channel 26865(831.5MHz)	Channel 26775(822.5MHz)
QPSK	23.9	23.9	23.9
16QAM	22.9	22.9	22.9
LTE Band41	Conducted Power (dBm)		
	Channel41490(2680MHz)	Channel 40620(2593MHz)	Channel 39750(2506MHz)
QPSK	23.8	23.8	23.8
16QAM	22.8	22.8	22.8
LTE Band66	Conducted Power (dBm)		
	Channel 132572(1770MHz)	Channel 132322(1745MHz)	Channel 133072(1720MHz)

QPSK	24.6	24.6	24.6
16QAM	23.6	23.6	23.6
LTE Band71	**Conducted Power (dBm)**		
	Channel 133372(688MHz)	**Channel 133322(683MHz)**	**Channel 133222(673MHz)**
QPSK	24	24	24
16QAM	23	23	23
2.4GHz 802.11b	**Conducted Power (dBm)**		
	Channel 11 (2462MHz)	**Channel 6 (2437MHz)**	**Channel 1 (2412MHz)**
	16.9	16.9	16.9
5GHz	**Conducted Power (dBm)**		
	Channel 48 (5240MHz)	**Channel 44 (5220MHz)**	**Channel 36 (5180MHz)**
	13.6	13.6	13.6

5 Reference Documents

5.1 Reference Documents for testing

The following document listed in this section is referred for testing.

Reference	**Title**	**Version**
ANSI C63.19-2011	American National Standard for Methods of Measurement of Compatibility between Wireless Communication Devices and Hearing Aids	2011 Edition
FCC 47 CFR §20.19	Hearing Aid Compatible Mobile Headsets	2015 Edition
KDB 285076 D01	Equipment Authorization Guidance for Hearing Aid Compatibility	v05r01

6 OPERATIONAL CONDITIONS DURING TEST

6.1 HAC MEASUREMENT SET-UP

These measurements are performed using the DASY5 NEO automated dosimetric assessment system. It is made by Schmid & Partner Engineering AG (SPEAG) in Zurich, Switzerland. It consists of high precision robotics system (Stäubli), robot controller, Intel Core2 computer, near-field probe, probe alignment sensor. The robot is a six-axis industrial robot performing precise movements. A cell controller system contains the power supply, robot controller, teach pendant (Joystick),and remote control, is used to drive the robot motors. The PC consists of the HP Intel Core21.86 GHz computer with Windows XP system and HAC Measurement Software DASY5 NEO, A/D interface card, monitor, mouse, and keyboard. The Stäubli Robot is connected to the cell controller to allow software manipulation of the robot. A data acquisition electronic (DAE)circuit performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. is connected to the Electro-optical coupler (EOC). The EOC performs the conversion from the optical into digital electric signal of the DAE and transfers data to the PC plug-in card.

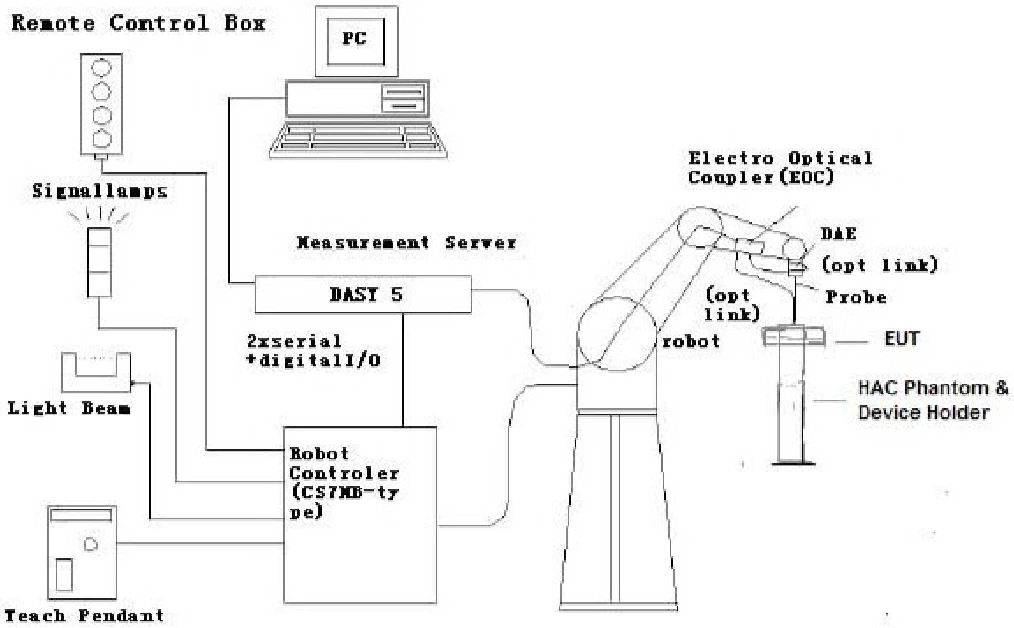


Fig. 1 HAC Test Measurement Set-up

The DAE4 consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the PC-card is accomplished through an optical downlink for data and status information and an optical uplink for commands and clock lines. The mechanical probe mounting device includes two different sensor systems for frontal and sidewise probe contacts. They are also used for mechanical surface detection and probe collision detection. The robot uses its own controller with a built in VME-bus computer.

6.2 Probe Specification

E-Field Probe Description

[ER3DV6]

Construction	One dipole parallel, two dipoles normal to probe axis Built-in shielding against static charges PEEK enclosure material
Calibration	In air from 100 MHz to 3.0 GHz (absolute accuracy ±6.0%, k=2)
Frequency	40 MHz to > 6 GHz (can be extended to < 20 MHz) Linearity: ± 0.2 dB (100 MHz to 3 GHz)
Directivity	± 0.2 dB in air (rotation around probe axis) ± 0.4 dB in air (rotation normal to probe axis)
Dynamic Range	2 V/m to > 1000 V/m; Linearity: ± 0.2 dB
Dimensions	Overall length: 330 mm (Tip: 16 mm) Tip diameter: 8 mm (Body: 12 mm) Distance from probe tip to dipole centers: 2.5 mm
Application	General near-field measurements up to 6 GHz Field component measurements Fast automatic scanning in phantoms

6.3Test Arch Phantom &Phone Positioner

The Test Arch phantom should be positioned horizontally on a stable surface. Reference markings on the Phantom allow the complete setup of all predefined phantom positions and measurement grids by manually teaching three points in the robot. It enables easy and well defined positioning of the phone and validation dipoles as well as simple teaching of the robot (Dimensions: 370 x 370 x 370 mm).

The Phone Positioner supports accurate and reliable positioning of any phone with effect on near field <±0.5 dB.

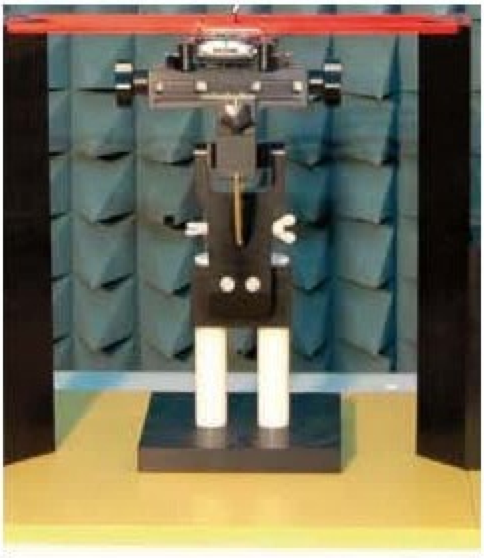


Fig. 2 HAC Phantom & Device Holder

6.4Robotic System Specifications

Specifications

Positioner: Stäubli Unimation Corp. Robot Model: RX160L
Repeatability: ±0.02 mm
No. of Axis: 6

Data Acquisition Electronic (DAE) System

Cell Controller
Processor: Intel Core2
Clock Speed: 1.86GHz
Operating System: Windows XP
Data Converter
Features: Signal Amplifier, multiplexer, A/D converter, and control logic
Software: DASY5 software
Connecting Lines: Optical downlink for data and status info.
Optical uplink for commands and clock

7 EUT ARRANGEMENT

7.1 WD RF Emission Measurements Reference and Plane

Figure 4 illustrates the references and reference plane that shall be used in the WD emissions measurement.

- The grid is 5 cm by 5 cm area that is divided into 9 evenly sized blocks or sub-grids.
- The grid is centered on the audio frequency output transducer of the WD (speaker or T-coil).
- The grid is located by reference to a reference plane. This reference plane is the planar area that contains the highest point in the area of the WD that normally rests against the user's ear
- The measurement plane is located parallel to the reference plane and 15 mm from it, out from the phone. The grid is located in the measurement plane.

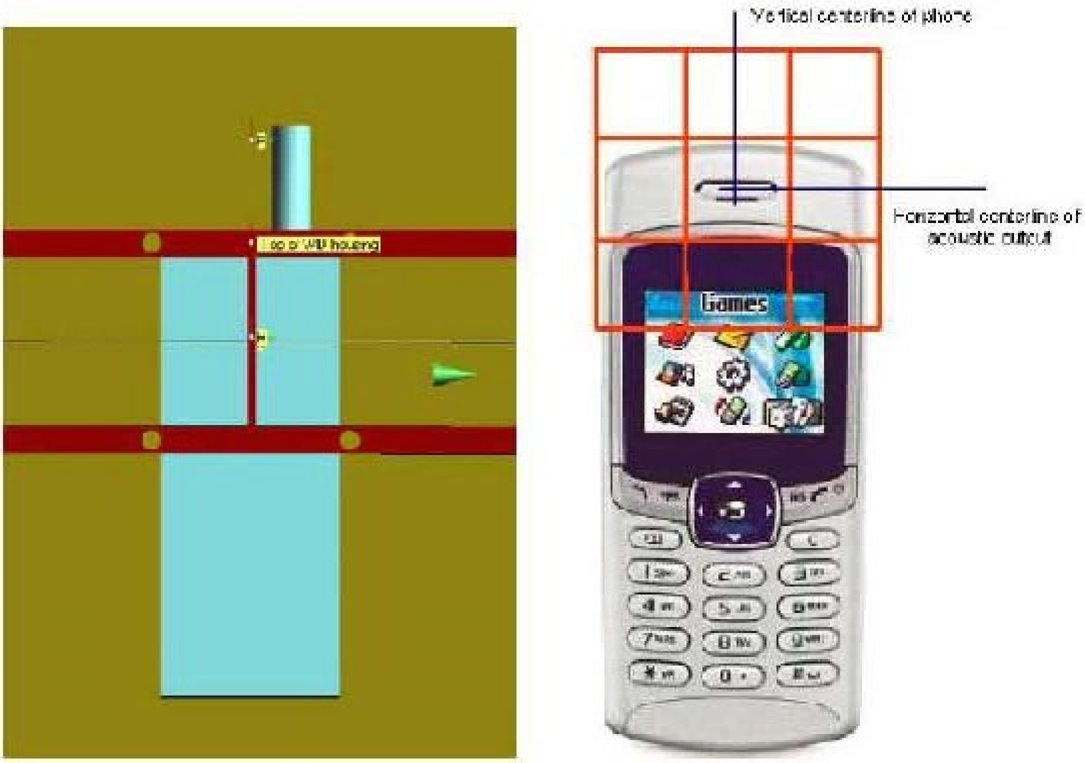


Fig. 3 WD reference and plane for RF emission measurements

8 SYSTEM VALIDATION

8.1 Validation Procedure

Place a dipole antenna meeting the requirements given in ANSI C63.19 in the position normally occupied by the WD. The dipole antenna serves as a known source for an electrical output. Position the E-field probes so that:

- The probes and their cables are parallel to the coaxial feed of the dipole antenna
- The probe cables and the coaxial feed of the dipole antenna approach the measurement area from opposite directions
- The center point of the probe element(s) are 15 mm from the closest surface of the dipole elements.

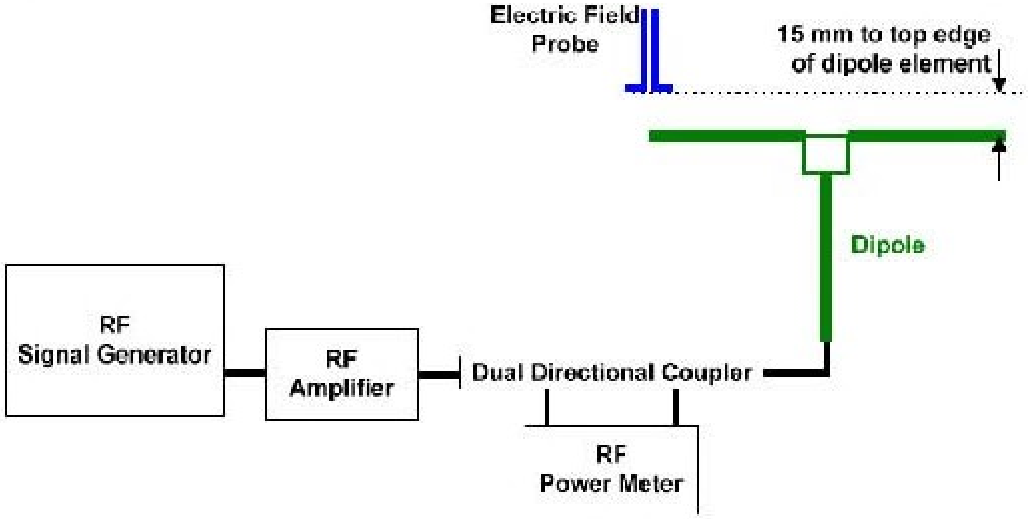


Fig. 4 Dipole Validation Setup

8.2 Validation Result

E-Field Scan						
Mode	Frequency (MHz)	Input Power (mW)	Measured[1] Value(dBV/m)	Target[2] Value(dBV/m)	Deviation[3] (%)	Limit[4] (%)
CW	835	100	40.31	40.64	-3.73	±25
CW	1880	100	38.88	38.87	0.12	±25
CW	2600	100	38.17	38.48	-3.51	±25

Notes:

1. Please refer to the attachment for detailed measurement data and plot.
2. Target value is provided by SPEAD in the calibration certificate of specific dipoles.
3. Deviation (%) = 100 * (Measured value minus Target value) divided by Target value.
4. ANSI C63.19 requires values within ± 25% are acceptable, of which 12% is deviation and 13% is measurement uncertainty. Values independently validated for the dipole actually used in the measurements should be used, when available.

9 Evaluation of MIF

9.1 Introduction

The MIF (Modulation Interference Factor) is used to classify E-field emission to determine Hearing Aid Compatibility (HAC). It scales the power-averaged signal to the RF audio interference level and is characteristic to a modulation scheme. The HAC standard preferred "indirect" measurement method is based on average field measurement with separate scaling by the MIF. With an Audio Interference Analyzer (AIA) designed by SPEAG specifically for the MIF measurement, these values have been verified by practical measurements on an RF signal modulated with each of the waveforms. The resulting deviations from the simulated values are within the requirements
of the HAC standard.

The AIA (Audio Interference Analyzer) is an USB powered electronic sensor to evaluate signals in the frequency range 698MHz - 6 GHz. It contains RMS detector and audio frequency circuits for sampling of the RF envelope.

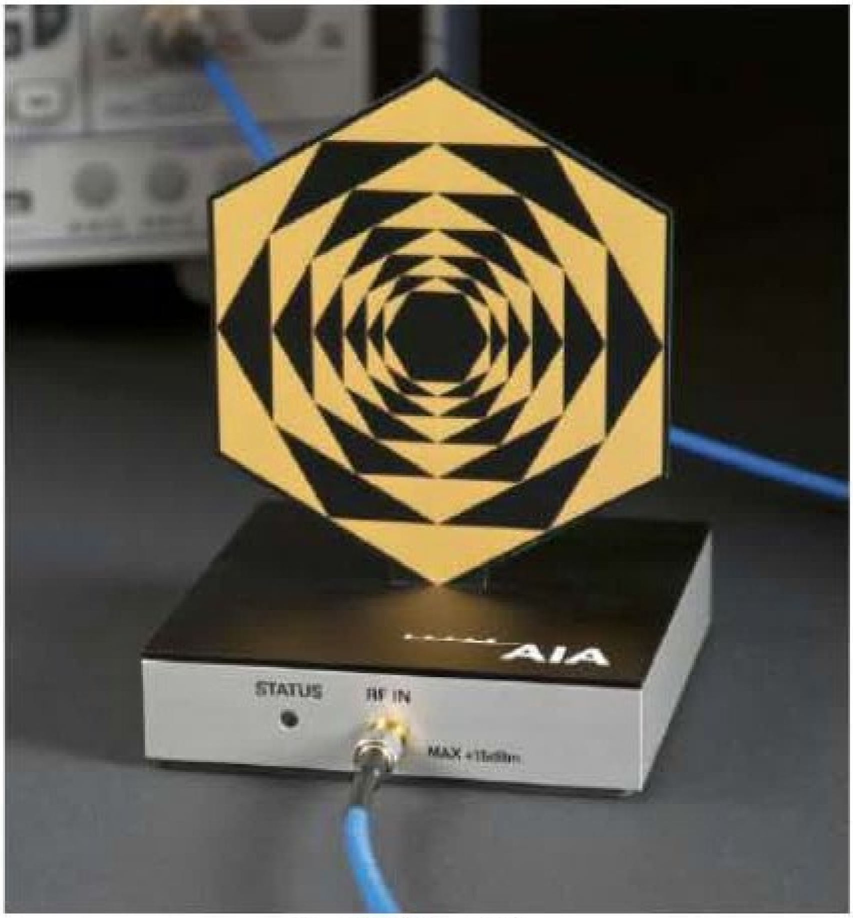


Fig. 5 AIA Front View

9.2 MIF measurement with the AIA

The MIF is measured with the AIA as follows:

1. Connect the AIA via USB to the DASY5 PC and verify the configuration settings.
2. Couple the RF signal to be evaluated to an AIA via cable or antenna.
3. Generate a MIF measurement job for the unknown signal and select the measurement port and timing settings.
4. Document the results via the post processor in a report.

9.3 Test equipment for the MIF measurement

No.	Name	Type	Serial Number	Manufacturer
01	Signal Generator	E4438C	MY49071430	Agilent
02	AIA	SE UMS 170 CB	1029	SPEAG
03	BTS	CMW500	166370	Agilent

9.4 DUT MIF results

Based on the KDB285076D01v05, the handset can also use the MIF values predetermined by the test equipment manufacturer. MIF values applied in this test report were provided by the HAC equipment provider of SPEAG, and the worst values for all air interface are listed below to be determine the Low-power Exemption.

Typical MIF levels in ANSI C63.19-2011	
Transmission protocol	Modulation interference factor
GSM-FDD (TDMA, GMSK)	+3.63 dB
UMTS-FDD(WCDMA, AMR)	-25.43dB
LTE-FDD (SC-FDMA, 1RB, 20MHz, QPSK)	-15.63 dB
LTE-FDD (SC-FDMA, 1RB, 20MHz, 16QAM)	-9.76 dB
LTE-TDD(SC-FDMA,1RB,20MHz,QPSK,UL Subframe=2,3,4,7,8,9)	-3.41 dB
LTE-TDD(SC-FDMA,1RB,20MHz,16QAM,UL Subframe=2,3,4,7,8,9)	-3.17 dB
IEEE 802.11b WiFi 2.4 GHz (DSSS, 1 Mbps)	-5.90 dB
IEEE 802.11b WiFi 2.4 GHz (DSSS, 2 Mbps)	-5.17 dB
IEEE 802.11b WiFi 2.4 GHz (DSSS, 5.5 Mbps)	-3.37 dB
IEEE 802.11b WiFi 2.4 GHz (DSSS, 11 Mbps)	-2.02 dB
IEEE 802.11g WiFi 2.4 GHz (DSSS-OFDM, 6 Mbps)	-0.36dB
IEEE 802.11n (HT Greenfield, 6.5 Mbps, BPSK)	-15.80 dB
IEEE 802.11a/h WiFi 5 GHz (OFDM, 6 Mbps)	-5.82 dB

Measured MIF for GSM							
Band		GSM 850			GSM 1900		
Channel		251	190	128	810	661	512
Mode	Voice	3.56	3.52	3.56	3.07	3.43	3.46

Measured MIF for WCDMA										
Band		WCDMA 850			WCDMA 1700			WCDMA 1900		
Channel		4458	4407	4357	1738	1637	1537	9938	9800	9662
Mode	RMC	-22.64	-23.51	-24.37	-22.91	-23.62	-24.15	-23.36	-23.87	-23.51

QPSK

Measured MIF levels		
Band	Channel	Modulation interference factor
Band12	23130	-14.54
	23095	-14.29
	23060	-13.96
Band13	23230	-14.26
Band25	26590	-14.06
	26365	-14.34
	26140	-13.94
Band26	26990	-14.67
	26865	-14.15
	26750	-14.62
Band66	132572	-14.32
	132322	-14.64
	132072	-14.58
Band71	133372	-14.74
	133322	-14.72
	133222	-14.96
Band41	41490	-4.62
	41055	-3.53
	40620	-3.46
	40185	-3.45
	39750	-3.98

16-QAM

Measured MIF levels		
Band	Channel	Modulation interference factor
Band12	23130	-10.16
	23095	-10.04

	23060	-10.71
Band13	23230	-10.47
Band25	26590	-10.13
	26365	-10.28
	26140	-11.01
Band26	26990	-11.14
	26865	-10.69
	26750	-10.89
Band66	132572	-10.33
	132322	-10.93
	132072	-10.59
Band71	133372	-11.08
	133322	-11.13
	133222	-10.97
Band41	41490	-3.67
	41055	-3.67
	40620	-3.46
	40185	-3.25
	39750	-3.28

2.4GHz 802.11b	11	-6.52
	6	-6.87
	1	-6.23
5GHz 802.11a	48	-1.76
	44	-1.49
	36	-2.36

10 Evaluation for low-power exemption

10.1 Product testing threshold

There are two methods for exempting an RF air interface technology from testing. The first method requires evaluation of the MIF for the worst-case operating mode. An RF air interface technology of a device is exempt from testing when its average antenna input power plus its MIF is≤17 dBm for any of its operating modes. The second method does not require determination of the MIF. The RF emissions testing exemption shall be applied to an RF air interface technology in a device whose peak antenna input power, averaged over intervals ≤50 μs20, is ≤23 dBm. An RF air interface technology that is exempted from testing by either method shall be rated as M4.

The first method is used to be exempt from testing for the RF air interface technology in this report.

10.2 Conducted power

Band	Average power (dBm)	MIF (dB)	Sum (dBm)	C63.19 Tested
GSM 850 - Voice	33.2	3.56	36.76	Yes
GSM 1900 - Voice	29.8	3.46	33.26	Yes
WCDMA 850 - RMC	23.1	-22.64	0.46	No
WCDMA 1700 - RMC	23.1	-22.91	0.19	No
WCDMA 1900 - RMC	23	-23.36	-0.36	No
LTE Band 12 QPSK	23.6	-13.96	9.64	No
LTE Band 13 QPSK	23.2	-14.26	8.94	No
LTE Band 25 QPSK	23.9	-13.94	9.96	No
LTE Band 26 QPSK	23.9	-14.15	9.75	No
LTE Band 66 QPSK	24.6	-14.32	10.28	No
LTE Band 71 QPSK	24	-14.72	9.28	No
LTE Band 41 QPSK	23.8	-3.45	20.35	Yes
LTE Band 12 16QAM	22.6	-10.04	12.56	No
LTE Band 13 16QAM	22.2	-10.47	11.73	No
LTE Band 25 16QAM	22.9	-10.13	12.77	No
LTE Band 26 16QAM	22.9	-10.69	12.21	No
LTE Band 66 16QAM	23.6	-10.33	13.27	No
LTE Band 71 16QAM	23	-10.97	12.03	No
LTE Band 41 16QAM	22.8	-3.25	19.55	Yes
WiFi-2.4G	16.9	-6.23	10.67	No
WiFi-5G	13.6	-1.49	12.11	No

10.3 Conclusion

According to the above table, the sums of average power and MIF for WCDMA LTE FDD and WiFi are less than 17dBm. So it is measured for GSM and LTE TDD bands. The WCDMA LTE FDD and WiFi are exempt from testing and rated as M4.

11 RF TEST PROCEDUERES

The evaluation was performed with the following procedure:

1) Confirm proper operation of the field probe, probe measurement system and other instrumentation and the positioning system.

2) Position the WD in its intended test position. The gauge block can simplify this positioning.

3) Configure the WD normal operation for maximum rated RF output power, at the desired channel and other operating parameters (e.g., test mode), as intended for the test.

4) The center sub-grid shall centered on the center of the T-Coil mode axial measurement point or the acoustic output, as appropriate. Locate the field probe at the initial test position in the50 mm by 50 mm grid, which is contained in the measurement plane. If the field alignment method is used, align the probe for maximum field reception.

5) Record the reading.

6) Scan the entire 50 mm by 50 mm region in equally spaced increments and record the reading at each measurement point. The distance between measurement points shall be sufficient to assure the identification of the maximum reading.

7) Identify the five contiguous sub-grids around the center sub-grid whose maximum reading is the lowest of all available choices. This eliminates the three sub-grids with the maximum readings. Thus, the six areas to be used to determine the WD's highest emissions are identified.

8) Identify the maximum field reading within the non-excluded sub-grids identified in Step 7)

9) Evaluate the MIF and add to the maximum steady-state rms field-strength reading to obtain the RF audio interference level..

10) Compare this RF audio interference level with the categories and record the resulting WD category rating.

12 Measurement Results (E-Field)

Frequency		Measured Value(dBV/m)	Power Drift (dB)	Category
MHz	Channel			
GSM 850				
848.8	251	34.86	0.05	**M4**
836.6	190	34.33	0.04	**M4**
824.2	128	34.93	0.01	**M4** (see Fig B.1)
GSM 1900				
1909.8	810	28.53	0.14	**M4**
1880	661	29.80	-0.1	**M4**
1850.2	512	30.49	0.18	**M3** (see Fig B.2)
LTE Band 41 QPSK				
2680	41490	18.96	-0.02	**M4**
2636.5	41055	20.27	0.07	**M4** (see Fig B.3)
2593	40620	18.79	0.17	**M4**
2549.5	40185	18.06	0.07	**M4**
2506	39750	16.57	-0.04	**M4**
LTE Band 41 16QAM				
2680	41490	19.32	0.04	**M4**
2636.5	41055	17.94	0.08	**M4**
2593	40620	19.54	0.14	**M4**
2549.5	40185	17.63	0.09	**M4**
2506	39750	11.17	0.05	**M4**

13 ANSIC 63.19-2011 LIMITS

WD RF audio interference level categories in logarithmic units

Emission categories	< 960 MHz E-field emissions	
Category M1	50 to 55	dB (V/m)
Category M2	45 to 50	dB (V/m)
Category M3	40 to 45	dB (V/m)
Category M4	< 40	dB (V/m)
Emission categories	**> 960 MHz E-field emissions**	
Category M1	40 to 45	dB (V/m)
Category M2	35 to 40	dB (V/m)
Category M3	30 to 35	dB (V/m)
Category M4	< 30	dB (V/m)

14 MEASUREMENT UNCERTAINTY

No.	Error source	Type	Uncertainty Value(%)	Prob. Dist.	k	c_iE	Standard Uncertainty (%) u_i' (%)E	Degree of freedom V_{eff} or v_i
Measurement System								
1	Probe Calibration	B	5.	N	1	1	5.1	∞
2	Axial Isotropy	B	4.7	R	$\sqrt{3}$	1	2.7	∞
3	Sensor Displacement	B	16.5	R	$\sqrt{3}$	1	9.5	∞
4	Boundary Effects	B	2.4	R	$\sqrt{3}$	1	1.4	∞
5	Linearity	B	4.7	R	$\sqrt{3}$	1	2.7	∞
6	Scaling to Peak Envelope Power	B	2.0	R	$\sqrt{3}$	1	1.2	∞
7	System Detection Limit	B	1.0	R	$\sqrt{3}$	1	0.6	∞
8	Readout Electronics	B	0.3	N	1	1	0.3	∞
9	Response Time	B	0.8	R	$\sqrt{3}$	1	0.5	∞
10	Integration Time	B	2.6	R	$\sqrt{3}$	1	1.5	∞
11	RF Ambient Conditions	B	3.0	R	$\sqrt{3}$	1	1.7	∞
12	RF Reflections	B	12.0	R	$\sqrt{3}$	1	6.9	∞
13	Probe Positioner	B	1.2	R	$\sqrt{3}$	1	0.7	∞
14	Probe Positioning	A	4.7	R	$\sqrt{3}$	1	2.7	∞
15	Extra. And Interpolation	B	1.0	R	$\sqrt{3}$	1	0.6	∞
Test Sample Related								
16	Device Positioning Vertical	B	4.7	R	$\sqrt{3}$	1	2.7	∞
17	Device Positioning Lateral	B	1.0	R	$\sqrt{3}$	1	0.6	∞
18	Device Holder and Phantom	B	2.4	R	$\sqrt{3}$	1	1.4	∞
19	Power Drift	B	5.0	R	$\sqrt{3}$	1	2.9	∞

20	AIA measurement	B	12	R	$\sqrt{3}$	1	6.9	∞
Phantom and Setup related								
21	Phantom Thickness	B	2.4	R	$\sqrt{3}$	1	1.4	∞
Combined standard uncertainty(%)							16.2	
Expanded uncertainty (confidence interval of 95 %)		$u_e = 2u_c$		N	k=2		32.4	

15 MAIN TEST INSTRUMENTS

Table 1: List of Main Instruments

No.	Name	Type	Serial Number	Calibration Date	Valid Period
01	Signal Generator	E4438C	MY49071430	February 01, 2021	One Year
02	Power meter	NRP2	101919	June 16, 2020	One year
03	Power sensor	NRP-Z91	101547		
04	Amplifier	60S1G4	0331848	No Calibration Requested	
05	E-Field Probe	EF3DV3	4060	May 29, 2020	One year
06	DAE	SPEAG DAE4	1555	August 25, 2020	One year
07	HAC Dipole	CD835V3	1023	August 18, 2020	One year
08	HAC Dipole	CD1880V3	1018	August 18, 2020	One year
09	HAC Dipole	CD2600V3	1017	August 18, 2020	One year
10	BTS	CMW500	166370	June 28, 2020	One year
11	AIA	SE UMS 170 CB	1029	No Calibration Requested	

16 CONCLUSION

The HAC measurement indicates that the EUT complies with the HAC limits of the ANSIC63.19-2011. The total M-rating is **M3.**

END OF REPORT BODY

ANNEX A TEST LAYOUT

Picture A1:HAC RF System Layout

ANNEX B TEST PLOTS

HAC RF E-Field GSM 850 Low

Date: 2021-3-10

Electronics: DAE4 Sn1555

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m^3

Ambient Temperature: 22.0°C

Communication System: GSM 850; Frequency: 824.2 MHz; Duty Cycle: 1:8.3

Probe: EF3DV3 - SN4060;ConvF(1, 1, 1)

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 45.50 V/m; Power Drift = 0.01 dB

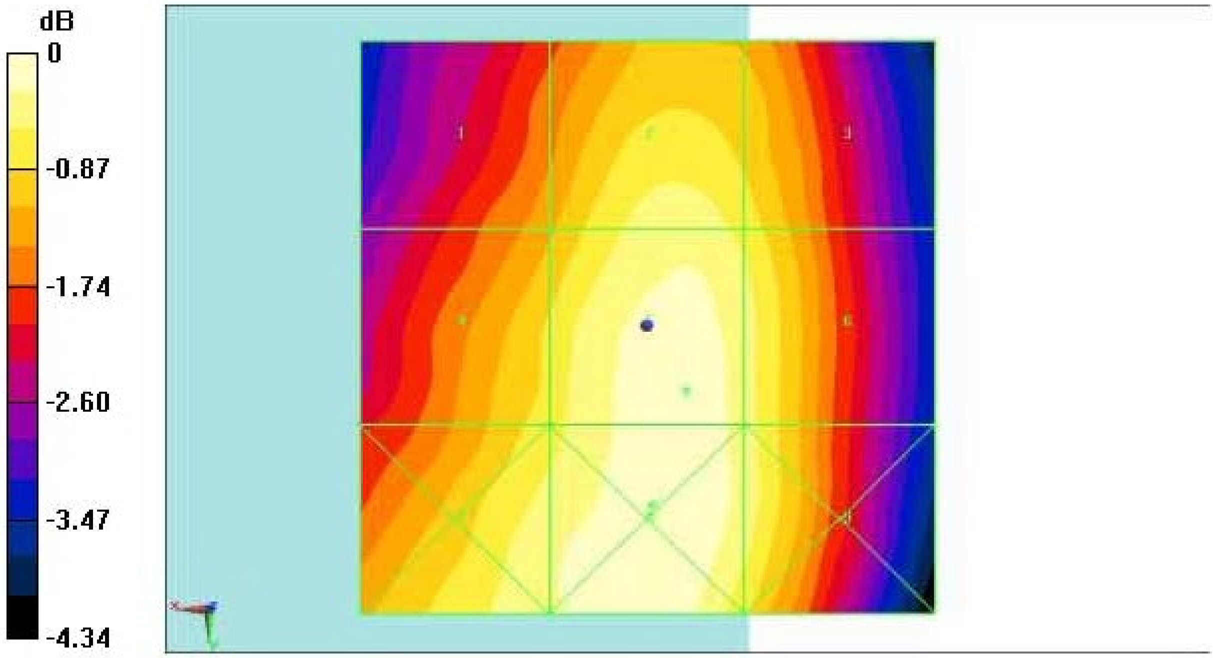
Applied MIF = 3.56 dB

RF audio interference level = 34.93 dBV/m

Emission category: M4

MIF scaled E-field

Grid 1 **M4** **33.82 dBV/m**	Grid 2 **M4** **34.62 dBV/m**	Grid 3 **M4** **34.34 dBV/m**
Grid 4 **M4** **34.34 dBV/m**	Grid 5 **M4** **34.93 dBV/m**	Grid 6 **M4** **34.6 dBV/m**
Grid 7 **M4** **34.7 dBV/m**	Grid 8 **M4** **35.03 dBV/m**	Grid 9 **M4** **34.64 dBV/m**



0 dB = 56.41 V/m = 35.03 dBV/m

Fig B.1 HAC RF E-Field GSM850 Low

HAC RF E-Field GSM 1900 Low

Date: 2021-3-11

Electronics: DAE4 Sn1555

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m^3

Ambient Temperature: 22.0°C

Communication System: PCS 1900; Frequency: 1850.2 MHz; Duty Cycle: 1:8.3

Probe: EF3DV3 - SN4060;ConvF(1, 1, 1)

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device 2 2 2 2/Hearing Aid Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 23.20 V/m; Power Drift = 0.18 dB

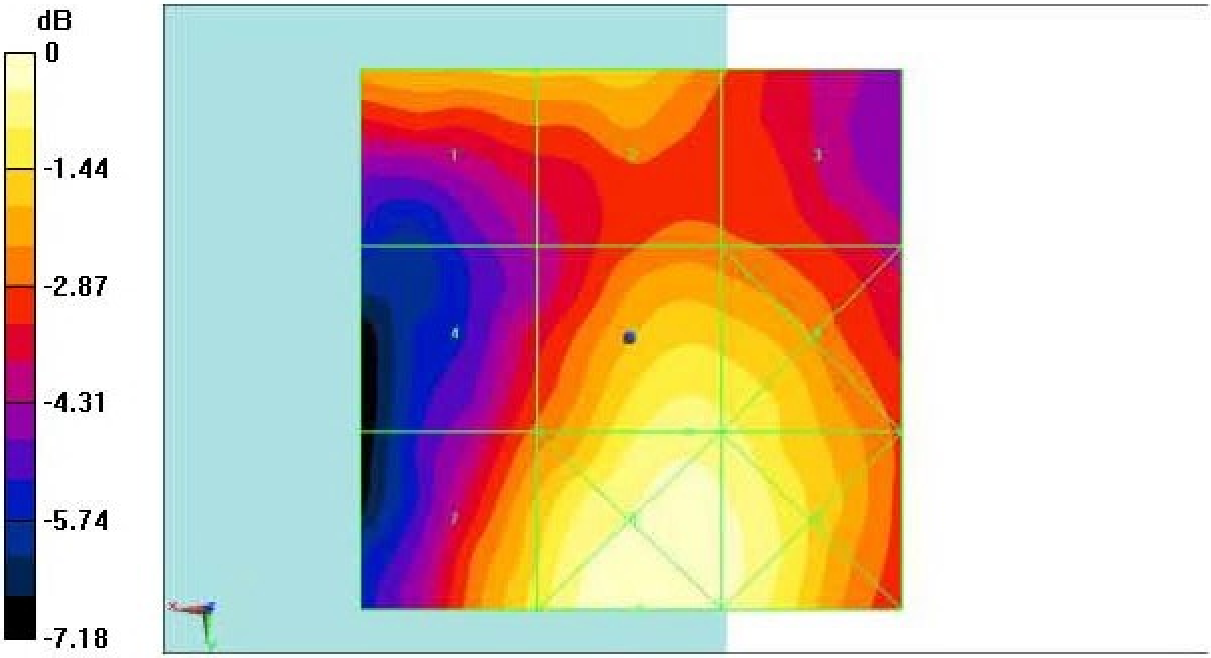
Applied MIF = 3.46 dB

RF audio interference level = 30.49 dBV/m

Emission category: M3

MIF scaled E-field

Grid 1 **M4** **29.5 dBV/m**	Grid 2 **M4** **29.59 dBV/m**	Grid 3 **M4** **28.45 dBV/m**
Grid 4 **M4** **28.47 dBV/m**	Grid 5 **M3** **30.49 dBV/m**	Grid 6 **M3** **30.36 dBV/m**
Grid 7 **M4** **30 dBV/m**	Grid 8 **M3** **31.16 dBV/m**	Grid 9 **M3** **30.89 dBV/m**



0 dB = 36.13 V/m = 31.16 dBV/m

Fig B.2 HAC RF E-Field GSM 1900 Low

HAC RF E-Field LTE Band41 QPSK CH41055

Date: 2021-3-13

Electronics: DAE4 Sn1555

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m^3

Ambient Temperature: 22.0°C

Communication System: LTE Band41; Frequency: 2636.5 MHz; Duty Cycle: 1:1.58

Probe: EF3DV3 - SN4060;ConvF(1, 1, 1)

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device

2/Hearing Aid Compatibility Test (101x101x1): Interpolated grid:

dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 11.44 V/m; Power Drift = 0.07 dB

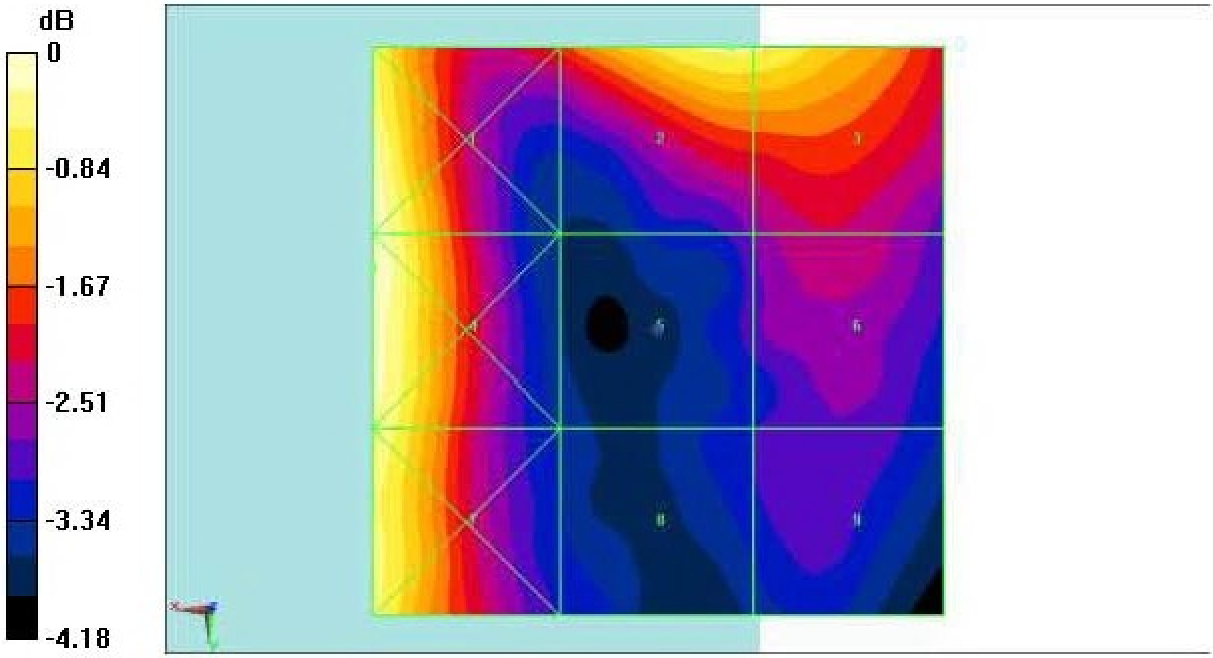
Applied MIF = -3.53 dB

RF audio interference level = 20.27 dBV/m

Emission category: M4

MIF scaled E-field

Grid 1 **M4** **20.64 dBV/m**	Grid 2 **M4** **20.27 dBV/m**	Grid 3 **M4** **20.23 dBV/m**
Grid 4 **M4** **20.69 dBV/m**	Grid 5 **M4** **17.99 dBV/m**	Grid 6 **M4** **18.45 dBV/m**
Grid 7 **M4** **20.41 dBV/m**	Grid 8 **M4** **17.64 dBV/m**	Grid 9 **M4** **17.91 dBV/m**



0 dB = 10.83 V/m = 20.69 dBV/m

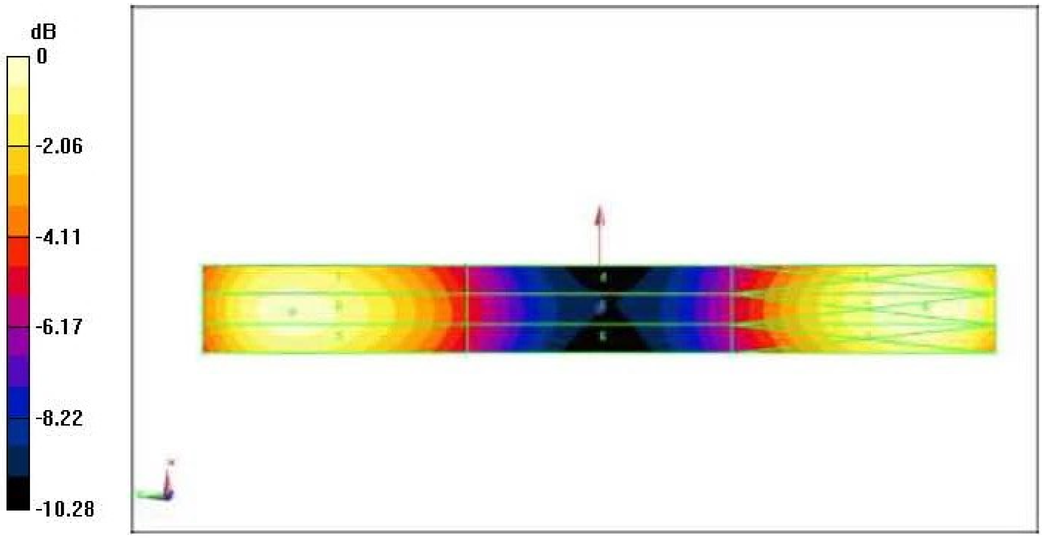
Fig B.3 HAC RF E-Field LTE Band41 QPSK CH41055

ANNEX C SYSTEM VALIDATION RESULT

E SCAN of Dipole 835 MHz
Date: 2021-3-10
Electronics: DAE4 Sn1555
Medium: Air
Medium parameters used: σ = 0 mho/m, εr = 1; ρ = 1000 kg/m3
Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1
Probe: EF3DV3 - SN4060;ConvF(1, 1, 1)
E Scan - measurement distance from the probe sensor center to CD835 Dipole = 15mm/Hearing Aid Compatibility Test (41x361x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 122.8 V/m; Power Drift = 0.04 dB
Applied MIF = 0.00 dB
RF audio interference level = 40.31 dBV/m
Emission category: M3

MIF scaled E-field

Grid 1 **M3** **40.47 dBV/m**	Grid 2 **M3** **40.58 dBV/m**	Grid 3 **M3** **40.41 dBV/m**
Grid 4 **M4** **35.62 dBV/m**	Grid 5 **M4** **35.82 dBV/m**	Grid 6 **M4** **35.71 dBV/m**
Grid 7 **M3** **40.1 dBV/m**	Grid 8 **M3** **40.31 dBV/m**	Grid 9 **M3** **40.22 dBV/m**

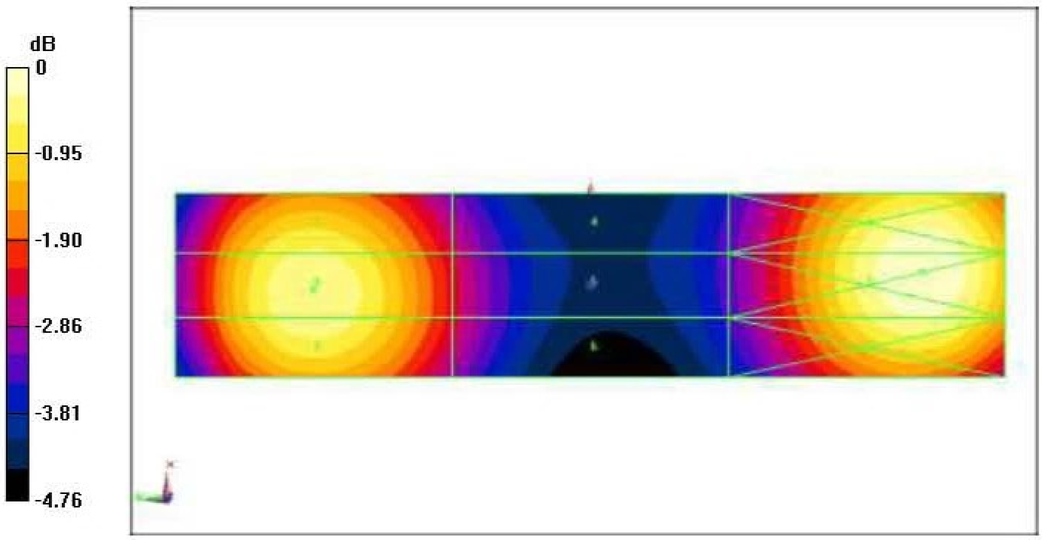


0 dB = 106.9 V/m = 40.58 dBV/m

E SCAN of Dipole 1880MHz
Date: 2021-3-11
Electronics: DAE4 Sn1555
Medium: Air
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m^3
Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1
Probe: EF3DV3 - SN4060;ConvF(1, 1, 1)
E Scan - measurement distance from the probe sensor center to CD1880 Dipole = 15mm/Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 118.8 V/m; Power Drift = -0.04 dB
Applied MIF = 0.00 dB
RF audio interference level = 38.88 dBV/m
Emission category: M2

MIF scaled E-field

Grid 1 **M2** **39.14 dBV/m**	Grid 2 **M2** **39.19 dBV/m**	Grid 3 **M2** **38.89 dBV/m**
Grid 4 **M2** **36.72 dBV/m**	Grid 5 **M2** **36.88 dBV/m**	Grid 6 **M2** **36.83 dBV/m**
Grid 7 **M2** **38.62 dBV/m**	Grid 8 **M2** **38.88 dBV/m**	Grid 9 **M2** **38.8 dBV/m**

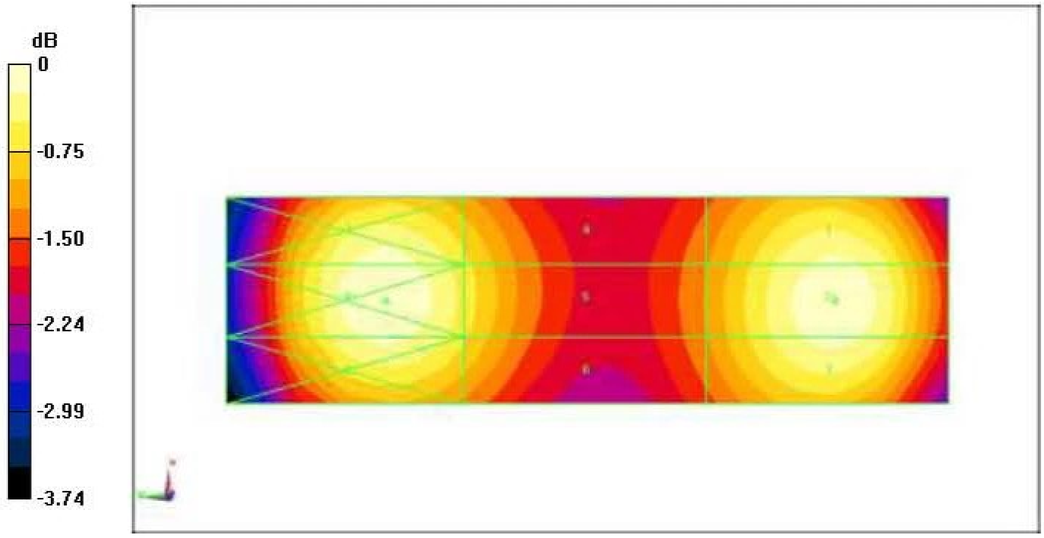


0 dB = 91.14 V/m = 39.19 dBV/m

E SCAN of Dipole 2600 MHz
Date: 2021-3-13
Electronics: DAE4 Sn1555
Medium: Air
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m^3
Communication System: CW; Frequency: 2600 MHz; Duty Cycle: 1:1
Probe: EF3DV3 - SN4060;ConvF(1, 1, 1)
E Scan - measurement distance from the probe sensor center to CD2600 Dipole = 15mm/Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 58.48 V/m; Power Drift = 0.02 dB
Applied MIF = 0.00 dB
RF audio interference level = 38.17 dBV/m
Emission category: M2

MIF scaled E-field

Grid 1 **M2** **38.04 dBV/m**	Grid 2 **M2** **38.17 dBV/m**	Grid 3 **M2** **38.07 dBV/m**
Grid 4 **M2** **37.56 dBV/m**	Grid 5 **M2** **37.63 dBV/m**	Grid 6 **M2** **37.51 dBV/m**
Grid 7 **M2** **38.09 dBV/m**	Grid 8 **M2** **38.22 dBV/m**	Grid 9 **M2** **38.04 dBV/m**



0 dB = 81.50 V/m = 38.22 dBV/m

ANNEX D PROBE CALIBRATION CERTIFICATE

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland

S Schweizerischer Kalibrierdienst
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Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 0108**

Client **CTTL (Auden)**

Certificate No: **EF3-4060_May20**

CALIBRATION CERTIFICATE

Object	EF3DV3- SN:4060
Calibration procedure(s)	QA CAL-02.v9, QA CAL-25.v7 Calibration procedure for E-field probes optimized for close near field evaluations in air
Calibration date:	May 29, 2020

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Calibration
Power meter NRP	SN: 104778	01-Apr-20 (No. 217-03100/03101)	Apr-21
Power sensor NRP-Z91	SN: 103244	01-Apr-20 (No. 217-03100)	Apr-21
Power sensor NRP-Z91	SN: 103245	01-Apr-20 (No. 217-03101)	Apr-21
Reference 20 dB Attenuator	SN: CC2552 (20x)	31-Mar-20 (No. 217-03106)	Apr-21
DAE4	SN: 789	27-Dec-19 (No. DAE4-789_Dec19)	Dec-20
Reference Probe ER3DV6	SN: 2328	05-Oct-19 (No. ER3-2328_Oct19)	Oct-20
Secondary Standards	ID	Check Date (in house)	Scheduled Check
Power meter E4419B	SN: GB41293874	06-Apr-16 (in house check Jun-18)	In house check: Jun-20
Power sensor E4412A	SN: MY41498087	06-Apr-16 (in house check Jun-18)	In house check: Jun-20
Power sensor E4412A	SN: 000110210	06-Apr-16 (in house check Jun-18)	In house check: Jun-20
RF generator HP 8648C	SN: US3642U01700	04-Aug-99 (in house check Jun-18)	In house check: Jun-20
Network Analyzer E8358A	SN: US41080477	31-Mar-14 (in house check Oct-19)	In house check: Oct-20

	Name	Function	Signature
Calibrated by:	Michael Weber	Laboratory Technician	M.Weber
Approved by:	Katja Pokovic	Technical Manager	

Issued: June 1, 2020

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: EF3-4060_May20 Page 1 of 21

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland

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Swiss Calibration Service

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Accreditation No.: SCS 0108

Glossary:

NORMx,y,z	sensitivity in free space
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C, D	modulation dependent linearization parameters
En	incident E-field orientation normal to probe axis
Ep	incident E-field orientation parallel to probe axis
Polarization φ	φ rotation around probe axis
Polarization ϑ	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., ϑ = 0 is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

a) IEEE Std 1309-2005, " IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005
b) CTIA Test Plan for Hearing Aid Compatibility, Rev 3.1.1, May 2017

Methods Applied and Interpretation of Parameters:

- *NORMx,y,z:* Assessed for E-field polarization ϑ = 0 for XY sensors and ϑ = 90 for Z sensor (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
- *NORM(f)x,y,z = NORMx,y,z * frequency_response* (see Frequency Response Chart).
- *DCPx,y,z:* DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- *PAR:* PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- *Ax,y,z; Bx,y,z; Cx,y,z; Dx,y,z; VRx,y,z: A, B, C, D* are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. *VR* is the maximum calibration range expressed in RMS voltage across the diode.
- *Spherical isotropy (3D deviation from isotropy):* in a locally homogeneous field realized using an open waveguide setup.
- *Sensor Offset:* The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- *Connector Angle*: The angle is assessed using the information gained by determining the *NORMx* (no uncertainty required).

DASY/EASY - Parameters of Probe: EF3DV3 - SN:4060

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm ($\mu V/(V/m)^2$)	0.79	0.74	1.28	± 10.1 %
DCP (mV)[B]	95.3	97.8	96.5	

Calibration results for Frequency Response (30 MHz – 6 GHz)

Frequency MHz	Target E-Field V/m	Measured E-field (En) V/m	Deviation E-normal in %	Measured E-field (Ep) V/m	Deviation E-normal in %	Unc (k=2) %
30	77.2	77.3	0.1%	77.3	0.1%	± 5.1 %
100	77.3	78.2	1.2%	78.5	1.5%	± 5.1 %
450	77.1	78.1	1.2%	78.2	1.4%	± 5.1 %
600	77.2	77.7	0.6%	77.7	0.7%	± 5.1 %
750	77.3	77.4	0.3%	77.4	0.3%	± 5.1 %
1800	140.3	138.3	-2.8%	139.2	-2.1%	± 5.1 %
2000	133.0	131.4	-2.7%	131.4	-2.7%	± 5.1 %
2200	125.1	123.5	-3.3%	124.5	-2.5%	± 5.1 %
2500	123.7	122.4	-2.5%	123.2	-1.8%	± 5.1 %
3000	78.9	75.8	-4.6%	76.7	-3.4%	± 5.1 %
3500	250.5	247.6	-3.3%	243.6	-4.8%	± 5.1 %
3700	244.2	239.8	-3.9%	237.6	-4.8%	± 5.1 %
5200	50.8	51.3	1.1%	51.7	1.8%	± 5.1 %
5500	49.7	49.4	-0.6%	48.2	-3.1%	± 5.1 %
5800	48.9	48.6	-0.6%	49.7	1.7%	± 5.1 %

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

[A] Numerical linearization parameter: uncertainty not required.
[B] Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

DASY/EASY - Parameters of Probe: EF3DV3 - SN:4060

Calibration Results for Modulation Response

UID	Communication System Name		A dB	B dB√μV	C	D dB	VR mV	Max dev.	Max Unc[E] (k=2)
0	CW	X	0.00	0.00	1.00	0.00	125.9	± 3.5 %	± 4.7 %
		Y	0.00	0.00	1.00		166.9		
		Z	0.00	0.00	1.00		128.4		
10352-AAA	Pulse Waveform (200Hz, 10%)	X	2.22	64.12	8.85	10.00	60.0	± 2.9 %	± 9.6 %
		Y	3.72	69.58	11.72		60.0		
		Z	2.68	66.15	10.03		60.0		
10353-AAA	Pulse Waveform (200Hz, 20%)	X	1.05	61.61	6.69	6.99	80.0	± 1.0 %	± 9.6 %
		Y	2.73	69.71	10.89		80.0		
		Z	1.39	64.06	8.17		80.0		
10354-AAA	Pulse Waveform (200Hz, 40%)	X	0.64	61.95	5.93	3.98	95.0	± 0.8 %	± 9.6 %
		Y	20.00	88.10	15.51		95.0		
		Z	1.00	65.44	7.85		95.0		
10355-AAA	Pulse Waveform (200Hz, 60%)	X	0.66	64.74	6.65	2.22	120.0	± 1.0 %	± 9.6 %
		Y	20.00	93.78	17.20		120.0		
		Z	20.00	84.41	12.55		120.0		
10387-AAA	QPSK Waveform, 1 MHz	X	1.98	70.59	17.17	1.00	150.0	± 1.9 %	± 9.6 %
		Y	1.94	69.99	16.92		150.0		
		Z	2.02	71.47	17.51		150.0		
10388-AAA	QPSK Waveform, 10 MHz	X	2.54	70.83	17.55	0.00	150.0	± 1.1 %	± 9.6 %
		Y	2.51	70.47	17.33		150.0		
		Z	2.43	70.41	17.43		150.0		
10396-AAA	64-QAM Waveform, 100 kHz	X	2.34	69.66	19.06	3.01	150.0	± 1.1 %	± 9.6 %
		Y	2.49	70.33	19.41		150.0		
		Z	2.09	67.16	17.82		150.0		
10399-AAA	64-QAM Waveform, 40 MHz	X	3.51	67.32	16.24	0.00	150.0	± 1.0 %	± 9.6 %
		Y	3.62	67.78	16.40		150.0		
		Z	3.52	67.45	16.34		150.0		
10414-AAA	WLAN CCDF, 64-QAM, 40MHz	X	4.74	65.60	15.79	0.00	150.0	± 2.0 %	± 9.6 %
		Y	4.72	65.49	15.68		150.0		
		Z	4.73	65.70	15.88		150.0		

Note: For details on UID parameters see Appendix

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

[B] Numerical linearization parameter: uncertainty not required.
[E] Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

DASY/EASY - Parameters of Probe: EF3DV3 - SN:4060

Sensor Frequency Model Parameters

	Sensor X	Sensor Y	Sensor Z
Frequency Corr. (LF)	0.20	0.19	4.60
Frequency Corr. (HF)	2.82	2.82	2.82

Sensor Model Parameters

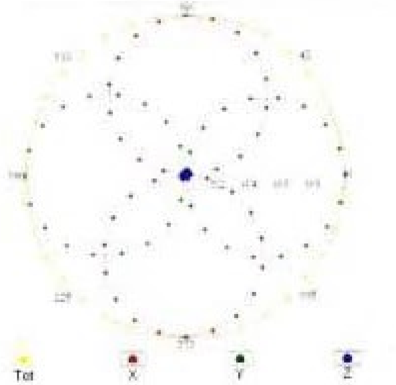
	C1 fF	C2 fF	α V^{-1}	T1 $ms.V^{-2}$	T2 $ms.V^{-1}$	T3 ms	T4 V^{-2}	T5 V^{-1}	T6
X	39.4	262.85	37.46	5.11	0.07	4.93	0.89	0.00	1.00
Y	40.3	265.26	36.67	6.10	0.00	4.98	1.07	0.00	1.00
Z	37.4	250.57	37.84	4.63	0.03	4.97	0.00	0.14	1.00

Other Probe Parameters

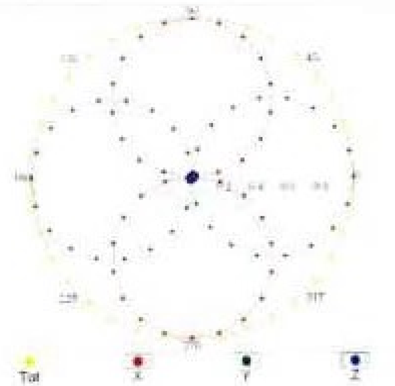
Sensor Arrangement	Rectangular
Connector Angle (°)	-35
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	12 mm
Tip Length	25 mm
Tip Diameter	4 mm
Probe Tip to Sensor X Calibration Point	1.5 mm
Probe Tip to Sensor Y Calibration Point	1.5 mm
Probe Tip to Sensor Z Calibration Point	1.5 mm

Receiving Pattern (ϕ), $\vartheta = 0°$

f=600 MHz,TEM,0°

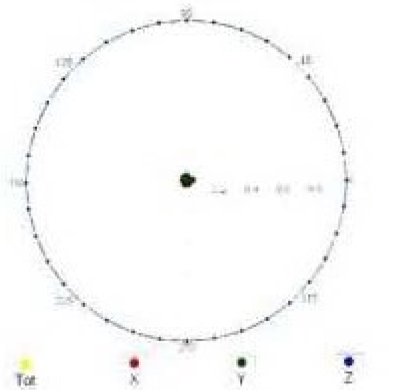


f=1800 MHz,R22,0°



Receiving Pattern (ϕ), $\vartheta = 90°$

f=600 MHz,TEM,90°



f=1800 MHz,R22,90°